HIGH VOLTAGE MEDIUM CURRENT DRIVER ARRAYS

DESCRIPTION

The SG2000 series integrates seven NPN Darlington pairs with internal suppression diodes to drive lamps, relays, and solenoids in many military, aerospace, and industrial applications that require severe environments. All units feature open collector outputs with greater than 50V breakdown voltages combined with 500mA current carrying capabilities. Five different input configurations provide optimized designs for interfacing with DTL, TTL, PMOS, or CMOS drive signals. These devices are designed to operate from -55°C to 125°C ambient temperature in a 16 pin dual in line ceramic (J) package and 20 pin Leadless Chip Carrier (LCC). The plastic dual in–line (N) is designed to operate over the commercial temperature range of 0°C to 70°C.

FEATURES

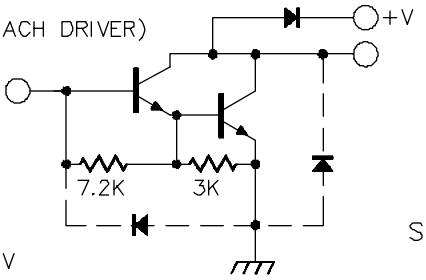
- **Seven npn Darlington pairs**
- **-55°C to 125°C ambient operating temperature range**
- **Collector currents to 600mA**
- **Output voltages from 50V to 95V**
- **Internal clamping diodes for inductive loads**
- **DTL, TTL, PMOS, or CMOS compatible inputs**
- **Hermetic ceramic package**

HIGH RELIABILITY FEATURES

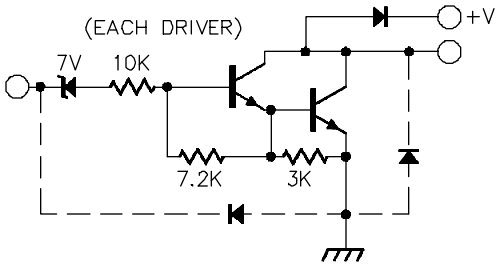
- **Available to MIL-STD-883 and DESC SMD**
- **MIL-M38510/14101BEA - JAN2001J**
- **MIL-M38510/14102BEA - JAN2002J**
- **MIL-M38510/14103BEA - JAN2003J**
- **MIL-M38510/14104BEA - JAN2004J**
- **Radiation data available**
- **LMI level "S" processing available**

PARTIAL SCHEMATICS

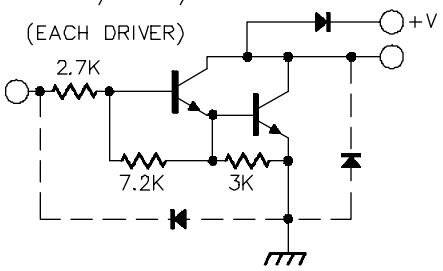
SG2001/2011/2021



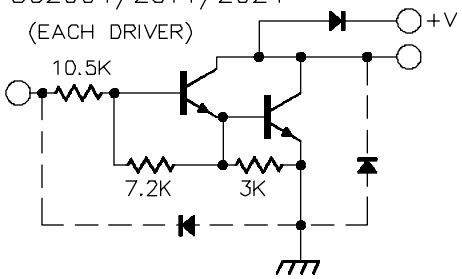
SG2002/2012



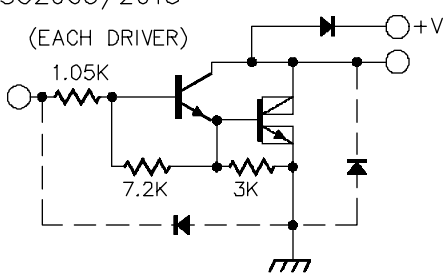
SG2003/2013/2023



SG2004/2014/2024



SG2005/2015



Copyright © 1997

LINFINITY Microelectronics Inc.
11861 Western Avenue ∞ Garden Grove, CA 92841
(714) 898-8121 ∞ FAX: (714) 893-2570

ABSOLUTE MAXIMUM RATINGS (Note 1)

Output Voltage, V_{CE}
(SG2000, 2010 series) 50V
(SG2020 series) 95V
Input Voltage, V_{IN}
(SG2002,3,4) 30V
Continuous Input Current, I_{IN} 25mA

Peak Collector Current, I_C
(SG2000, 2020) 500mA
(SG2010) 600mA
Operating Junction Temperature
Hermetic (J, L Packages) ..... 150°C
Plastic (N, Packages) ..... 150°C
Storage Temperature Range ..... -65°C to 150°C
Lead Temperature (Soldering 10 sec.) ..... 300°C

Note 1. Values beyond which damage may occur.

THERMAL DATA

J Package:
Thermal Resistance-Junction to Case, θ_{JC} ..... 30°C/W
Thermal Resistance-Junction to Ambient, θ_{JA} ..... 80°C/W
N Package:
Thermal Resistance-Junction to Case, θ_{JC} ..... 40°C/W
Thermal Resistance-Junction to Ambient, θ_{JA} ..... 65°C/W
L Package:
Thermal Resistance-Junction to Case, θ_{JC} ..... 35°C/W
Thermal Resistance-Junction to Ambient, θ_{JA} ..... 120°C/W

Note A. Junction Temperature Calculation: $T_J = T_A + (P_D \times \theta_{JA})$.
Note B. The above numbers for θ_{JC} are maximums for the limiting thermal resistance of the package in a standard mounting configuration. The θ_{JA} numbers are meant to be guidelines for the thermal performance of the device/pc-board system. All of the above assume no ambient airflow.

RECOMMENDED OPERATING CONDITIONS (Note 2)

Output Voltage, V_{CE}
SG2000, SG2010 series 50V
SG2020 series 95V

Peak Collector Current, I_C
SG2000, SG2020 series 50mA
SG2010 series 500mA
Operating Ambient Temperature Range
SG2000 Series - Hermetic ..... -55°C to 125°C
SG2000 Series - Plastic ..... 0°C to 70°C

Note 2. Range over which the device is functional.

SELECTION GUIDE

Device	V_{CE} Max	I_C Max	Logic Inputs
SG2001	50V	500mA	General Purpose PMOS, CMOS
SG2002	50V	500mA	14V-25V PMOS
SG2003	50V	500mA	5V TTL, CMOS
SG2004	50V	500mA	6V-15V CMOS, PMOS
SG2011	50V	600mA	General Purpose PMOS, CMOS
SG2012	50V	600mA	14V-25V PMOS

Device	V_{CE} Max	I_C Max	Logic Inputs
SG2013	50V	600mA	5V TTL, CMOS
SG2014	50V	600mA	6V-15V CMOS, PMOS
SG2015	50V	600mA	High Output TTL
SG2021	95V	500mA	General Purpose PMOS, CMOS
SG2023	95V	500mA	5V TTL, CMOS
SG2024	95V	500mA	6V-15V CMOS, PMOS

Copyright © 1997

LINFINITY Microelectronics Inc.
11861 Western Avenue ∞ Garden Grove, CA 92841
(714) 898-8121 ∞ FAX: (714) 893-2570

ELECTRICAL CHARACTERISTICS

(Unless otherwise specified, these specifications apply over the operating ambient temperatures for SG2000 series - Hermetic - with -55°C ≤ T_A ≤ 125°C and SG2000 series - Plastic - with 0°C ≤ T_A ≤ 70°C. Low duty cycle pulse testing techniques are used which maintains junction and case temperatures equal to the ambient temperature.)

SG2001 thru SG2004

Parameter	Applicable Devices	Temp.	Test Conditions	Limits			Units
				Min.	Typ.	Max.	
Output Leakage Current (I_{CEX})	All		V_{CE} = 50V			100	µA
	SG2002		V_{CE} = 50V, V_{IN} = 6V			500	µA
	SG2004		V_{CE} = 50V, V_{IN} = 1V			500	µA
Collector - Emitter ($V_{CE(SAT)}$)	All	$T_A = T_{MIN}$	I_C = 350mA, I_B = 850µA		1.6	1.8	V
		$T_A = T_{MIN}$	I_C = 200mA, I_B = 550µA		1.3	1.5	V
		$T_A = T_{MIN}$	I_C = 100mA, I_B = 350µA		1.1	1.3	V
		T_A = 25°C	I_C = 350mA, I_B = 500µA		1.25	1.6	V
		T_A = 25°C	I_C = 200mA, I_B = 350µA		1.1	1.3	V
		T_A = 25°C	I_C = 100mA, I_B = 250µA		0.9	1.1	V
		$T_A = T_{MAX}$	I_C = 350mA, I_B = 500µA		1.6	1.8	V
		$T_A = T_{MAX}$	I_C = 200mA, I_B = 350µA		1.3	1.5	V
		$T_A = T_{MAX}$	I_C = 100mA, I_B = 250µA		1.1	1.3	V
Input Current ($I_{IN(ON)}$)	SG2002		V_{IN} = 17V	480	850	1300	µA
	SG2003		V_{IN} = 3.85V	650	930	1350	µA
	SG2004		V_{IN} = 5V	240	350	500	µA
			V_{IN} = 12V	650	1000	1450	µA
($I_{IN(OFF)}$)	All	$T_A = T_{MAX}$	I_C = 500µA	25	50		µA
Input Voltage ($V_{IN(ON)}$)	SG2002	$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 300mA			18	V
		$T_A = T_{MAX}$	V_{CE} = 2V, I_C = 300mA			13	V
	SG2003	$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 200mA			3.3	V
		$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 250mA			3.6	V
		$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 300mA			3.9	V
		$T_A = T_{MAX}$	V_{CE} = 2V, I_C = 200mA			2.4	V
		$T_A = T_{MAX}$	V_{CE} = 2V, I_C = 250mA			2.7	V
		$T_A = T_{MAX}$	V_{CE} = 2V, I_C = 300mA			3.0	V
	SG2004	$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 125mA			6.0	V
		$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 200mA			8.0	V
		$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 275mA			10	V
		$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 350mA			12	V
		$T_A = T_{MAX}$	V_{CE} = 2V, I_C = 125mA			5.0	V
		$T_A = T_{MAX}$	V_{CE} = 2V, I_C = 200mA			6.0	V
		$T_A = T_{MAX}$	V_{CE} = 2V, I_C = 275mA			7.0	V
		$T_A = T_{MAX}$	V_{CE} = 2V, I_C = 350mA			8.0	V
D-C Forward Current	SG2001	$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 350mA	500			
Transfer Ratio (h_{FE})		T_A = 25°C	V_{CE} = 2V, I_C = 350mA	1000			
Input Capacitance (C_{IN}) (Note 3)	All	T_A = 25°C			15	25	pF
Turn-On Delay (TPLH)	All	T_A = 25°C	0.5 E_{IN} to 0.5 E_{OUT}		250	1000	ns
Turn-Off Delay (TPHL)	All	T_A = 25°C	0.5 E_{IN} to 0.5 E_{OUT}		250	1000	ns
Clamp Diode Leakage Current (I_R)	All		V_R = 50V			50	µA
Clamp Diode Forward Voltage (V_F)	All		I_F = 350mA		1.7	2.0	V

Note 3. These parameters, although guaranteed, are not tested in production.

Copyright © 1997

LINFINITY Microelectronics Inc.
11861 Western Avenue ∞ Garden Grove, CA 92841
(714) 898-8121 ∞ FAX: (714) 893-2570

ELECTRICAL CHARTACTERISTICS (continued)

SG2011 thru SG2015

Parameter	Applicable Devices	Temp.	Test Conditions	Limits			Units
				Min.	Typ.	Max.	
Output Leakage Current (I_{CEX})	All		V_{CE} = 50V			100	µA
	SG2012		V_{CE} = 50V, V_{IN} = 6V			500	µA
	SG2014		V_{CE} = 50V, V_{IN} = 1V			500	µA
Collector - Emitter ($V_{CE(SAT)}$)	All	$T_A = T_{MIN}$	I_C = 500mA, I_B = 1100µA		1.8	2.1	V
		$T_A = T_{MIN}$	I_C = 350mA, I_B = 850µA		1.6	1.8	V
		$T_A = T_{MIN}$	I_C = 200mA, I_B = 550µA		1.3	1.5	V
		T_A = 25°C	I_C = 500mA, I_B = 600µA		1.7	1.9	V
		T_A = 25°C	I_C = 350mA, I_B = 500µA		1.25	1.6	V
		T_A = 25°C	I_C = 200mA, I_B = 350µA		1.1	1.3	V
		$T_A = T_{MAX}$	I_C = 500mA, I_B = 600µA		1.8	2.1	V
		$T_A = T_{MAX}$	I_C = 350mA, I_B = 500µA		1.6	1.8	V
		$T_A = T_{MAX}$	I_C = 200mA, I_B = 350µA		1.3	1.5	V
Input Current ($I_{IN(ON)}$)	SG2012		V_{IN} = 17V	480	850	1300	µA
	SG2013		V_{IN} = 3.85V	650	930	1350	µA
	SG2014		V_{IN} = 5V	240	350	500	µA
			V_{IN} = 12V	650	1000	1450	µA
	SG2015		V_{IN} = 3V	1180	1500	2400	µA
($I_{IN(OFF)}$)	All	$T_A = T_{MAX}$	I_C = 500µA	25	50		µA
Input Voltage ($V_{IN(ON)}$)	SG2012	$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 500mA			23.5	V
		$T_A = T_{MAX}$	V_{CE} = 2V, I_C = 500mA			17	V
	SG2013	$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 250mA			3.6	V
		$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 300mA			3.9	V
		$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 500mA			6.0	V
		$T_A = T_{MAX}$	V_{CE} = 2V, I_C = 250mA			2.7	V
		$T_A = T_{MAX}$	V_{CE} = 2V, I_C = 300mA			3.0	V
		$T_A = T_{MAX}$	V_{CE} = 2V, I_C = 500mA			3.5	V
	SG2014	$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 275mA			10	V
		$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 350mA			12	V
		$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 500mA			17	V
		$T_A = T_{MAX}$	V_{CE} = 2V, I_C = 275mA			7.0	V
		$T_A = T_{MAX}$	V_{CE} = 2V, I_C = 350mA			8.0	V
		$T_A = T_{MAX}$	V_{CE} = 2V, I_C = 500mA			9.5	V
	SG2015	$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 350mA			3.0	V
		$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 500mA			3.5	V
		$T_A = T_{MAX}$	V_{CE} = 2V, I_C = 350mA			2.4	V
		$T_A = T_{MAX}$	V_{CE} = 2V, I_C = 500mA			2.6	V
D-C Forward Current	SG2011	$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 500mA	450			
Transfer Ratio (h_{FE})		T_A = 25°C	V_{CE} = 2V, I_C = 500mA	900			
Input Capacitance (C_{IN}) (Note 3)	All	T_A = 25°C			15	25	pF
Turn-On Delay (TPLH)	All	T_A = 25°C	0.5 E_{IN} to 0.5 E_{OUT}		250	1000	ns
Turn-Off Delay (TPHL)	All	T_A = 25°C	0.5 E_{IN} to 0.5 E_{OUT}		250	1000	ns
Clamp Diode Leakage Current (I_R)	All		V_R = 50V			50	µA
Clamp Diode Forward Voltage (V_F)	All		I_F = 350mA		1.7	2.0	V
			I_F = 500mA			2.5	V

Note 3. These parameters, although guaranteed, are not tested in production.

Copyright © 1997

LINFINITY Microelectronics Inc.
11861 Western Avenue ∞ Garden Grove, CA 92841
(714) 898-8121 ∞ FAX: (714) 893-2570

ELECTRICAL CHARACTERISTICS (continued)

SG2021 thru SG2024

Parameter	Applicable Devices	Temp.	Test Conditions	Limits			Units
				Min.	Typ.	Max.	
Output Leakage Current (I_{CEX})	All		V_{CE} = 95V			100	µA
	SG2024		V_{CE} = 95V, V_{IN} = 1V			500	µA
Collector - Emitter ($V_{CE(SAT)}$)	All	$T_A = T_{MIN}$	I_C = 350mA, I_B = 850µA		1.6	1.8	V
		$T_A = T_{MIN}$	I_C = 200mA, I_B = 550µA		1.3	1.5	V
		$T_A = T_{MIN}$	I_C = 100mA, I_B = 350µA		1.1	1.3	V
		T_A = 25°C	I_C = 350mA, I_B = 500µA		1.25	1.6	V
		T_A = 25°C	I_C = 200mA, I_B = 350µA		1.1	1.3	V
		T_A = 25°C	I_C = 100mA, I_B = 250µA		0.9	1.1	V
		$T_A = T_{MAX}$	I_C = 350mA, I_B = 500µA		1.6	1.8	V
		$T_A = T_{MAX}$	I_C = 200mA, I_B = 350µA		1.3	1.5	V
		$T_A = T_{MAX}$	I_C = 100mA, I_B = 250µA		1.1	1.3	V
Input Current ($I_{IN(ON)}$)	SG2023		V_{IN} = 3.85V	650	930	1350	µA
	SG2024		V_{IN} = 5V	240	350	500	µA
			V_{IN} = 12V	650	1000	1450	µA
($I_{IN(OFF)}$)	All	$T_A = T_{MAX}$	I_C = 500µA	25	50		µA
Input Voltage ($V_{IN(ON)}$)		$T_A = T_{MAX}$	V_{CE} = 2V, I_C = 300mA			13	V
	SG2023	$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 200mA			3.3	V
		$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 250mA			3.6	V
		$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 300mA			3.9	V
		$T_A = T_{MAX}$	V_{CE} = 2V, I_C = 200mA			2.4	V
		$T_A = T_{MAX}$	V_{CE} = 2V, I_C = 250mA			2.7	V
		$T_A = T_{MAX}$	V_{CE} = 2V, I_C = 300mA			3.0	V
	SG2024	$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 125mA			6.0	V
		$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 200mA			8.0	V
		$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 275mA			10	V
		$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 350mA			12	V
		$T_A = T_{MAX}$	V_{CE} = 2V, I_C = 125mA			5.0	V
		$T_A = T_{MAX}$	V_{CE} = 2V, I_C = 200mA			6.0	V
		$T_A = T_{MAX}$	V_{CE} = 2V, I_C = 275mA			7.0	V
		$T_A = T_{MAX}$	V_{CE} = 2V, I_C = 350mA			8.0	V
D-C Forward Current	SG2021	$T_A = T_{MIN}$	V_{CE} = 2V, I_C = 350mA	500			
Transfer Ratio (h_{FE})		T_A = 25°C	V_{CE} = 2V, I_C = 350mA	1000			
Input Capacitance (C_{IN}) (Note 3)	All	T_A = 25°C			15	25	pF
Turn-On Delay (TPLH)	All	T_A = 25°C	0.5 E_{IN} to 0.5 E_{OUT}		250	1000	ns
Turn-Off Delay (TPHL)	All	T_A = 25°C	0.5 E_{IN} to 0.5 E_{OUT}		250	1000	ns
Clamp Diode Leakage Current (I_R)	All		V_R = 95V			50	µA
Clamp Diode Forward Voltage (V_F)	All		I_F = 350mA		1.7	2.0	V

Note 3. These parameters, although guaranteed, are not tested in production.

Copyright © 1997

LINFINITY Microelectronics Inc.
11861 Western Avenue ∞ Garden Grove, CA 92841
(714) 898-8121 ∞ FAX: (714) 893-2570

CHARACTERISTIC CURVES

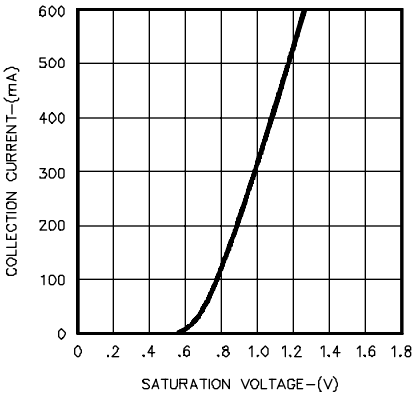


FIGURE 1.
OUTPUT CHARACTERISTICS

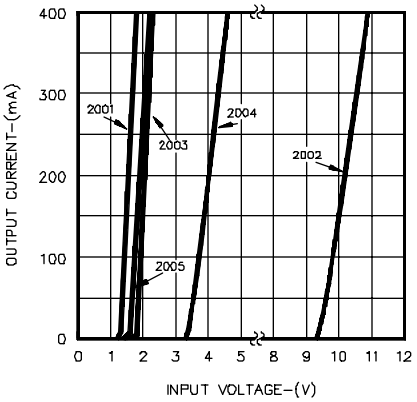


FIGURE 2.
OUTPUT CURRENT VS. INPUT VOLTAGE

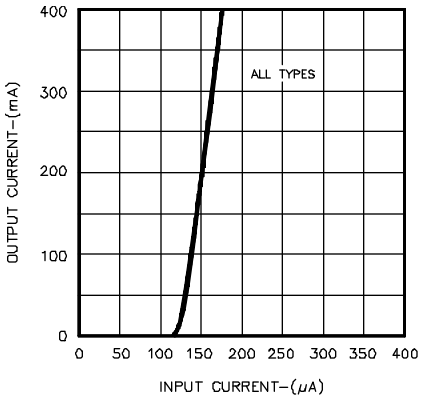


FIGURE 3.
OUTPUT CURRENT VS. INPUT CURRENT

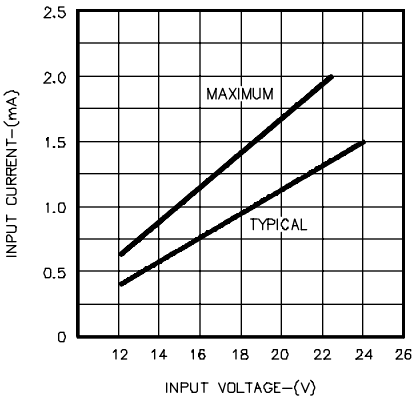


FIGURE 4.
INPUT CHARACTERISTICS - SG2002

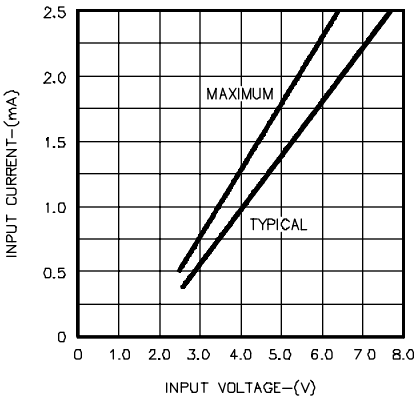


FIGURE 5.
INPUT CHARACTERISTICS - SG2003

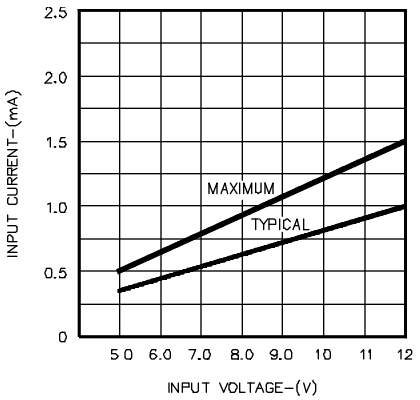


FIGURE 6.
INPUT CHARACTERISTICS - SG2004

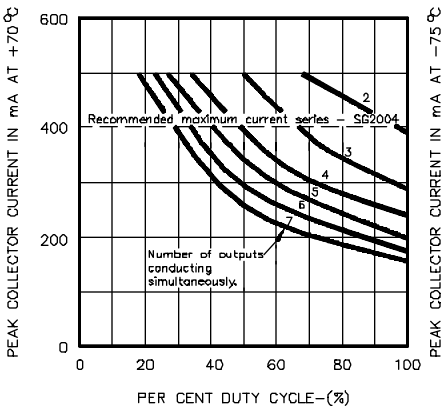
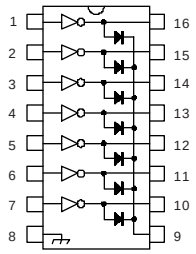
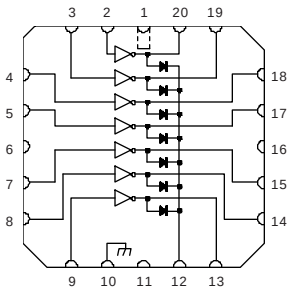


FIGURE 7.
PEAK COLLECTOR CURRENT VS. DUTY CYCLE

Copyright © 1997

LINFINITY Microelectronics Inc.
11861 Western Avenue ∞ Garden Grove, CA 92841
(714) 898-8121 ∞ FAX: (714) 893-2570

CONNECTION DIAGRAMS & ORDERING INFORMATION (See Notes Below)

Package	Part No. (Note 3)	Ambient Temperature Range	Connection Diagram
16-PIN CERAMIC DIP J - PACKAGE	SG2XXXJ/883B SG2023J/DESC JAN2001J JAN2002J JAN2003J JAN2004J SG2XXXJ	-55°C to 125°C -55°C to 125°C -55°C to 125°C -55°C to 125°C -55°C to 125°C -55°C to 125°C -55°C to 125°C	
16-PIN PLASTIC DIP N - PACKAGE	SG2003N SG2023N	0°C to 70°C 0°C to 70°C	
20-PIN CERAMIC LEADLESS CHIP CARRIER L- PACKAGE	SG2XXXL/883B SG2XXXL	-55°C to 125°C -55°C to 125°C	

Note 1. Contact factory for JAN and DESC product availability.
2. All parts are viewed from the top.
3. See selection guide for specific device types.

Copyright © 1997

LINFINITY Microelectronics Inc.
11861 Western Avenue ∞ Garden Grove, CA 92841
(714) 898-8121 ∞ FAX: (714) 893-2570